Issue Classification



Application/Control No.	Applicant(s)/Patent Under Reexamination
10764914	SIBRAI ET AL.

Examiner

Nguyen, Hiep

Art Unit
2816

ORIGINAL						INTERNATIONAL CLASSIFICATION										
CLASS SU					UBCLASS				С	LAIMED	NON-CLAIMED					
327 337						G	0	6	F	7 / 64 (2006.01	.01)					
CROSS REFERENCE(S)																
CLASS	CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)									***						
327	334	339	341	<u></u>		<u> </u>										
	ļ	<u> </u>				 	<u> </u>	_				-		-		
	 	 				┢					_			-		
					-	┢		-	_							
	 					\vdash					\dashv	<u> </u>				
						15		- 9				77	1			
									_							
												-			1.00	
	<u> </u>				-	-	-	-				ļ.,				
			· · · · · · · · · · · · · · · · · · ·			-	 	-		*	_					
·	<u> </u>	 	 		 	╆										
	 		_	ļ	 	-	-	\vdash	 			 				
 					 	\vdash	-	1				 				
· · · · · ·	 					T										
	1															
							<u> </u>	ļ								
	.					<u> </u>	<u> </u>	<u> </u>	ļ			<u> </u>		_		
	-		ļ	<u> </u>	ļ	4—	_		_			 				
						╂—	-	├	-			-	-		·	
	-	 	<u> </u>		 	╁		-				 				
	 	 	 		 	+	-	\vdash	 			 	-	+-		
		 				t		\vdash	 							
						十	_	<u> </u>	†			\top			().	
	1															
Nguyen, Hiep 01-18-08 (Assistant Examiner) (Date)				7						Total Claims Allowed:						
		SUPERVISORY PATENT EXAMINER							O.G. Print Claim(s)			O.G. Print Figure				
(Legal Instruments (Date) Examiner)				(Primary	(Primary Examiner) (Date) 0 - 09 - 08							1 9				